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PATENT 8-11-03

ARK OFFICE

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

MARIN re application of:

Sharad Kapur, et al.

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Serial No.:

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Technology Center 2100

Filed:

October 26, 1999

For:

SYSTEM AND METHOD FOR DETERMINING CAPACITANCE

FOR LARGE-SCALE INTEGRATED CIRCUITS

Group No.:

2123

Examiner:

Eduardo Garcia-Otero

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

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Sir:

AMENDMENT UNDER 37 C.F.R. § 1.111

The Applicants have carefully considered this application in connection with the Examiner's Action mailed on May 21, 2003, and respectfully request reconsideration of this application in view of the following amendment and remarks.